



#4
SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 3114-0025-0XPCT	SERIAL NO. 09/423,606	
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Kazutaka HAYASHI, et al.				
		FILING DATE November 12, 1999	GROUP 1762			
U.S. PATENT DOCUMENTS						
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
<i>sm</i>	AA	4,073,967	02/14/78	T. C. SANDVIG	427	44
	AB	3,412,063	11/19/68	E. D. JARBOE, et al.	260	37
	AC	4,941,993	07/17/90	P. STREHLOW, et al.	252	315,6
<i>sm</i>	AD	4,343,857	08/10/82	J. URAM, Jr.	428	336
	AE	5,520,952	05/28/96	K. TANITSU, et al.	427	58
	AF				RECEIVED	
	AG				MAY 24 2001	
	AH					
	AI				TC 1700	
	AJ					
	AK					
	AL					
	AM					
	AN					
FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO
<i>sm</i>	AO	0 524 417	01/27/93	EUROPE		X
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)						
	AW					
	AX					
	AY					
	AZ					
Examiner	<i>S. N. Nohr</i>				Date Considered	<i>11/13/01</i>
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.						

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 3114-0025-0X PCT		SERIAL NO. 09/423,606		
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		FILING DATE		November 12, 1999		GROUP		1762
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
AA		O 1	FEB 14 2000 PATENT & TRADEMARK OFFICE					
AB								
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FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	TRANSLATION NO		
<i>Sm</i>	AO	6-242432	09/02/94	JAPAN		X		
	AP							
	AQ							
	AR							
	AS							
	AT							
	AU							
	AV							
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW							
	AX							
	AY							
	AZ							
Examiner	<i>S.M. Nelson</i>		Date Considered 11-13-01					

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.